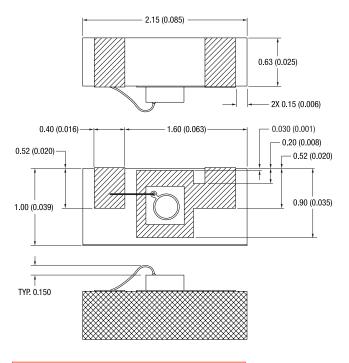
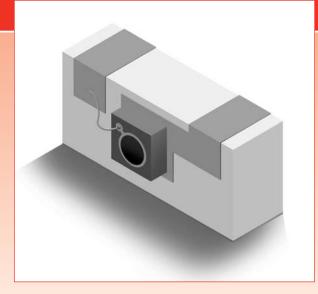
■FCI-InGaAs-XXX-WCER

High Speed InGaAs Photodiodes Mounted on Wraparound Ceramic Packages

FCI-InGaAs-XXX-WCER with active area sizes of 70µm, 120µm, 300µm, 400µm and 500µm are part of a line of monitor photodiodes mounted on metallized ceramic substrates. These compact assemblies are designed for ease of integration. The chips can be epoxy or eutectic mounted onto the ceramic substrate.



- All units in millimeters (inches).
- \bullet All devices are eutectic mounted with tolerance of $\pm 50 \mu m.$



APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitor
- Instrumentation

FEATURES

- Low Noise
- High Responsivity
- High Speed
- Spectral Range 900nm to 1700nm

Absolute Maximum Ratings													
PARAMETERS	SYMBOL	MIN	MAX	UNITS									
Storage Temperature	T _{stg}	-40	+85	°C									
Operating Temperature	T _{op}	0	+70	°C									
Soldering Temperature	T _{sld}		+260	°C									

Electro-Op	tical Ch	naracteristi	cs														T _A =2	3°C
PARAMETERS	CVMPOL	CONDITIONS	FCI-In	GaAs-70	WCER	FCI-InGaAs-120WCER			FCI-InGaAs-300WCER			R FCI-InGaAs-400WCER FCI-InGaAs-					0WCER	UNITS
PARAMETERS	STMBUL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Active Area Diameter	AA_{ϕ}			70			120			300			400			500		μm
Responsivity	R ₂	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
Responsivity	1 λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		7, **
Capacitance	C _j	$V_{R} = 5.0V$		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	I _d	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_R = 5.0V,$ $R_L = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Revervse Voltage					20			20			15			15			15	V
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

■FCI-InGaAs-XXX-ACER

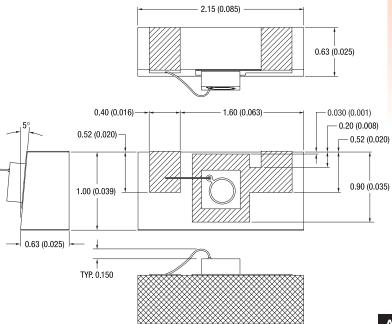
Notes:

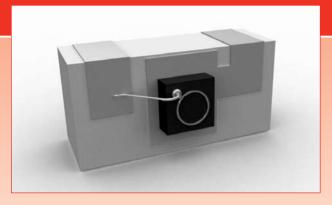
• All units in millimeters (inches).

 \bullet All devices are eutectic mounted with tolerance of $\pm 50 \mu m.$

High Speed InGaAs Photodiodes Mounted on Wedge Ceramic Packages

FCI-InGaAs-XXX-ACER with active area sizes of 70µm, 120µm, 300µm, 400μm and 500μm is part of OSI Optoelectronics's high speed IR sensitive photodiodes mounted on angled ceramic substrates. The ceramic substrate with an angled surface by 5° greatly reduces the back reflection. The chips can be epoxy/eutectic mounted onto the angled ceramic substrate.





• APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitor
- Instrumentation

• FEATURES

- 5° Angle Ceramic
- Low Noise
- High Responsivity
- High Speed
- Spectral Range 900nm to 1700nm

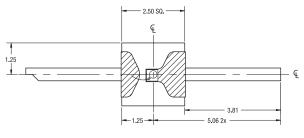
Absolute Maximum	Ratings			
PARAMETERS	SYMBOL	MIN	MAX	UNITS
Storage Temperature	T _{stg}	-40	+85	°C
Operating Temperature	T _{op}	0	+70	°C
Soldering Temperature	T _{sld}		+260	°C

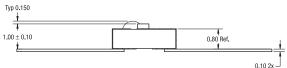
·		naracteristi		GaAs-7	DACER	FCI-InGaAs-120ACER FCI-InGaAs-300ACER			OACER	FCI-In	GaAs-40	OACER	FCI-In	GaAs-50		23°C		
PARAMETERS	SYMBOL	MBOL CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Active Area Diameter	AA_{ϕ}			70			120			300			400			500		μm
Despensivity	D.	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		μιτι
Responsivity	R _λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		A/W
Capacitance	C _j	V _R = 5.0V		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	I_d	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_R = 5.0V,$ $R_L = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Revervse Voltage					20			20			15			15			15	V
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

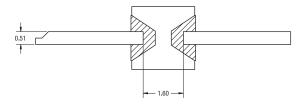
■FCI-InGaAs-XXX-LCER

High Speed InGaAs Photodiodes Mounted on Ceramic Packages w/Leads

FCI-InGaAs-XXX-LCER with active area sizes of 70µm, 120µm, 300µm, 400μm and 500μm are part of OSI Optoelectronics's high speed IR sensitive photodiodes mounted on gull wing ceramic substrates. The chips can be epoxy/eutectic mounted onto the ceramic substrate.

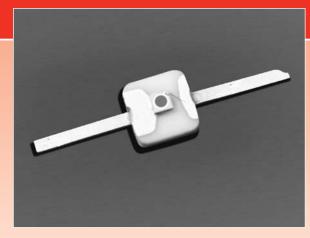






Notes:

- · All units in millimeters.
- All devices are mounted with low out gassing conductive epoxy with tolerance of ±25µm. Eutectic mounting is also available upon request.



APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitoring
- Instrumentation

FEATURES

- Low Noise
- High Responsivity
- High Speed
- Spectral Range 900nm to 1700nm

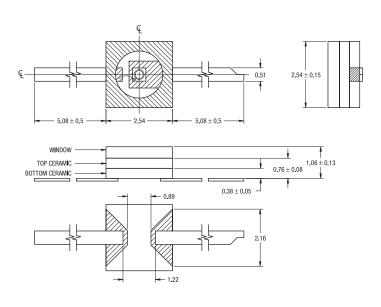
Absolute Maximum	Ratings			
PARAMETERS	SYMBOL	MIN	MAX	UNITS
Storage Temperature	T _{stg}	-40	+85	°C
Operating Temperature	T _{op}	0	+70	°C
Soldering Temperature	T _{sld}		+260	°C

Electro-Op	tical Cl	naracteristi	cs														T _A =	23°C
PARAMETERS	CVMPOL	CONDITIONS	FCI-InGaAs-70LCER			FCI-InGaAs-120LCER			FCI-InGaAs-300LCER			FCI-In	GaAs-40	OLCER	FCI-In	OLCER	UNITS	
PARAMETERS	STMBUL		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Active Area Diameter	AA_{ϕ}			70			120			300			400			500		μm
Responsivity	R _λ	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
Responsivity	ι _λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		A) W
Capacitance	C _j	V _R = 5.0V		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	I _d	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_R = 5.0V,$ $R_L = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Revervse Voltage					20			20			15			15			15	٧
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

■FCI-InGaAs-XXX-CCER

High Speed InGaAs Photodiodes Mounted on Cavity Ceramic Packages

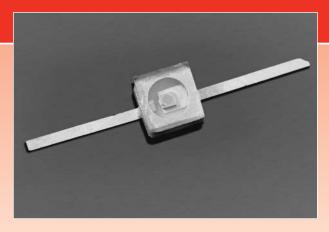
FCI-InGaAs-XXX-CCER with active area sizes of 70µm, 120µm, 300µm, 400µm and 500µm are part of OSI Optoelectronics's high speed IR sensitive photodiodes mounted on gull wing ceramic substrates with glass windows. These devices have a glass window attached to the ceramic where fibers can be directly epoxy mounted onto. The chips can be epoxy or eutectic mounted onto the ceramic substrate. These devices can be provided with custom AR coated windows.



· All units in millimeters.

Notes:

• All devices are mounted with low out gassing conductive epoxy with tolerance of ±25µm. Eutectic mounting is also available upon request.



APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitoring
- Instrumentation

FEATURES

- Low Noise
- High Responsivity
- High Speed
- Spectral Range 900nm to 1700nm

Absolute Maximum	Ratings			
PARAMETERS	SYMBOL	MIN	MAX	UNITS
Storage Temperature	T _{stg}	-40	+85	°C
Operating Temperature	T _{op}	0	+70	°C
Soldering Temperature	T _{sld}		+260	°C

Electro-Op	tical Ch	naracteristi	cs														T _A =	23°C
PARAMETERS	CVMPOL	CONDITIONS	FCI-InGaAs-70CCER			FCI-InGaAs-120CCER			FCI-InGaAs-300CCER			FCI-In	GaAs-40	OCCER	FCI-In	OCCER	UNITS	
PARAMETERS	STMBUL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Active Area Diameter	AA_{ϕ}			70			120			300			400			500		μm
Responsivity	R _a	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
Responsivity	Αλ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		Ayvv
Capacitance	C _j	V _R = 5.0V		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	I_d	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_R = 5.0V,$ $R_L = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Revervse Voltage					20			20			15			15			15	V
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz